Philips Semiconductors

Three quadrant triacs guaranteed commutation

GENERAL DESCRIPTION

QUICK REFERENCE DATA

PARAMETER

voltages

current

Repetitive peak off-state

Non-repetitive peak on-state

RMS on-state current

SYMBOL

VDRM

T(RMS)

I_{TSM}

Passivated guaranteed commutation triacs in a plastic envelope intended for use in motor control circuits or with other highly inductive loads. These devices balance the requirements of commutation performance and gate sensitivity. The "sensitive gate" E series and "logic level" D series are intended for interfacing with low power drivers, including micro controllers.

PINNING - TO220AB

PIN

1

2

3

tab

PIN CONFIGURATION

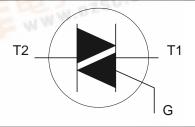
SYMBOL

BTA216-

BTA216-

BTA216-





LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX		
V _{drm}	Repetitive peak off-state voltages	IN MAL		-600 600 ¹	-800 800	V
I _{T(RMS)} I _{TSM}	RMS on-state current Non-repetitive peak on-state current	full sine wave; $T_{mb} \le 99 \degree C$ full sine wave; $T_j = 25 \degree C$ prior to surge	-	16		A
l ² t dI _T /dt	I ² t for fusing Repetitive rate of rise of on-state current after triggering	t = 20 ms t = 16.7 ms t = 10 ms I_{TM} = 20 A; I_G = 0.2 A; dI_G/dt = 0.2 A/µs	-	140 150 98 100		Α Α Α ² s Α/μs
I _{GM} V _{GM} P _{GM} P _{G(AV)}	Peak gate current Peak gate voltage Peak gate power Average gate power	over any 20 ms period	938	2 5 5 0.5		A V W W
T _{stg} T _j	Storage temperature Operating junction temperature	penod	-40 -	150 125		°C °C

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Product specification

MAX.

800E

800F

800

16

140

UNIT

V

А

А

BTA216 series D, E and F

MAX.

600D

600E

600F

600

16

140

Mithough not recommended, off-state voltages up to 800V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 A/µs.

BTA216 series D, E and F

THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R _{th j-mb} R _{th j-a}	,	full cycle half cycle in free air		- - 60	1.2 1.7 -	K/W K/W K/W

STATIC CHARACTERISTICS

 $T_i = 25$ °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.		MAX.		UNIT
		BTA216-			D	E	F	
I _{GT}	Gate trigger current ²	V _D = 12 V; I _T = 0.1 A T2+ G+ T2+ G-	-	1.3 2.6	5 5 5	10 10	25 25	mA mA
 I _L	Latching current	$T_2 - G_2$ $T_2 - G_2$ $V_D = 12 V; I_{GT} = 0.1 A$	-	3.4	5	10	25 25	mA
_		T2+ G+ T2+ G- T2- G-	- - -	10.2 11.3 19.3	15 25 25	25 30 30	30 40 40	mA mA mA
I _H	Holding current	V _D = 12 V; I _{GT} = 0.1 A	-	8	15	25	30	mA
					D, E, F			
$V_{T} V_{GT}$	On-state voltage Gate trigger voltage	$I_T = 20 \text{ A}$ $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$ $V_D = 400 \text{ V}; I_T = 0.1 \text{ A};$	- - 0.25	1.2 0.7 0.4		1.5 1.5 -		V V V
Ι _D	Off-state leakage current		-	0.1		0.5		mA

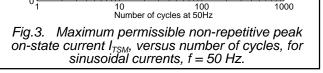
DYNAMIC CHARACTERISTICS

$T_j = 25$ °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS		MIN.		TYP.	MAX.	UNIT
		BTA216-	D	E	F	D		
dV _D /dt	Critical rate of rise of off-state voltage	$V_{DM} = 67\% V_{DRM(max)};$ $T_j = 110 °C; exponential waveform; gate open circuit$	30	60	70	65	-	V/µs
dl _{com} /dt	Critical rate of change of commutating current	$V_{DM} = 400 \text{ V}; \text{ T}_{j} = 110 \text{ °C};$ $I_{T(RMS)} = 16 \text{ A};$ $dV_{com}/dt = 20V/\mu \text{s}; \text{ gate}$ open circuit	2.5	4.7	9.5	7.5	-	A/ms
dl _{com} /dt	Critical rate of change of commutating current	$V_{DM} = 400 \text{ V}; \text{ T}_{j} = 110 ^{\circ}\text{C};$ $I_{T(RMS)} = 16 \text{ A};$ $dV_{com}/dt = 0.1 \text{V}/\mu\text{s}; \text{ gate}$ open circuit	12	40	50	100	-	A/ms
			D, E, F					
t _{gt}	Gate controlled turn-on time	$I_{TM} = 20 \text{ A}; V_D = V_{DRM(max)};$ $I_G = 0.1 \text{ A}; dI_G/dt = 5 \text{ A/}\mu\text{s}$	-	-	-	2	-	μs

2 Device does not trigger in the T2-, G+ quadrant.

25 Ptot / W Tmb(max) / C IT(RMS) / A 20 ∝= 180 99°C 101 20 120 15 90 15 107 60 10 30 10 13 5 119 5 __125 20 0 0 -50 5 10 IT(RMS) / A 15 50 Tmb / C 100 150 Fig.1. Maximum on-state dissipation, P_{tot} , versus rms on-state current, $I_{T(RMS)}$, where α = conduction angle. Fig.4. Maximum permissible rms current $I_{T(RMS)}$, versus mounting base temperature T_{mb} . 1000 ITSM IT(RMS) / A 50 40 dt limi 30 100 20 Ιтем 10 tim C max Ti initial 10 └─ 10us 0.01 100us 1ms 10ms 100ms 0.1 10 surge duration / s T/s Fig.2. Maximum permissible non-repetitive peak Fig.5. Maximum permissible repetitive rms on-state on-state current I_{TSM} , versus pulse width t_p , for sinusoidal currents, $t_p \le 20ms$. current $I_{T(RMS)}$, versus surge duration, for sinusoidal currents, f = 50 Hz; $T_{mb} \le 99$ °C. VGT(Tj) ITSM / 150 VGT(25°C 1.6 ITSM 1.4 time 100 Ti initial = 25°C may 1.2 1 50 0.8 0.6 0.4 <u>-</u>50 01 0 50 Ti∕°C 100 150



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Fig.6. Normalised gate trigger voltage

 $V_{GT}(T_i)/V_{GT}(25^{\circ}C)$, versus junction temperature T_i .

IGT(Tj) IGT(25°C)

3

25

2

1.5

1

0.5

0

3

2.5 2

1.5

1

0.5

0 ∟ -50

-50

IL(Tj) IL(25°C)

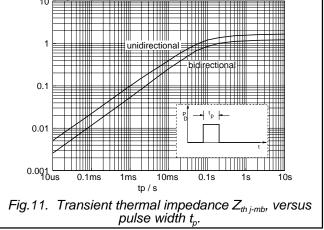
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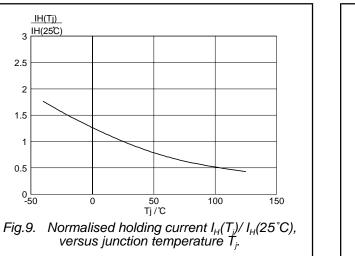
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0

0

50 [T / A Tj = 125 C Tj = 25 C -T2+G+ — T2+ Gtyp max T2- G-40 Vo = 1.195 V Rs = 0.018 Ohms 30 20 10 0∟ 0 150 0.5 1.5 VT / V 2 2.5 3 Fig.7. Normalised gate trigger current $I_{GT}(T_j)/I_{GT}(25^{\circ}C)$, versus junction temperature T_j . Fig.10. Typical and maximum on-state characteristic. 10 Zth j-mb (K/W)





100

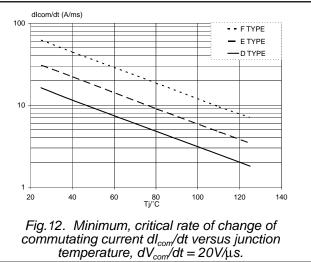
100

150

50 Ti∕°C

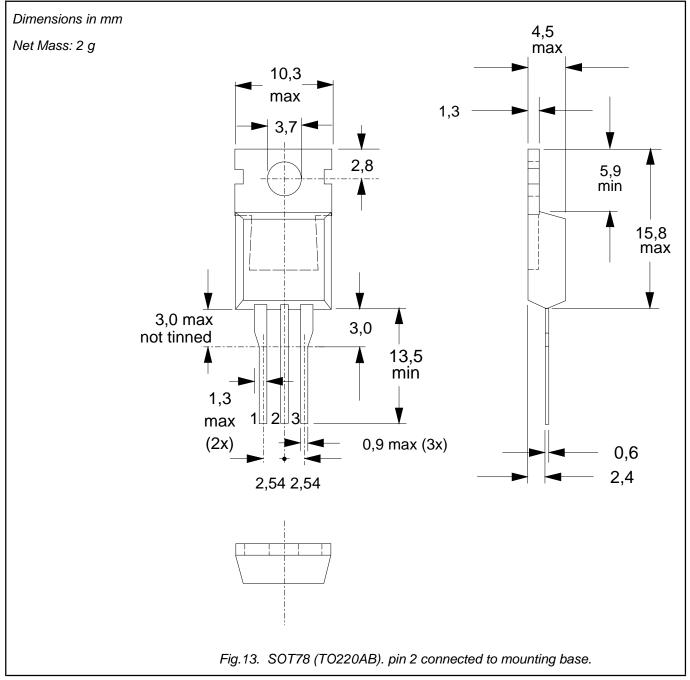
50 Tj /℃

Fig.8. Normalised latching current $I_L(T_j)/I_L(25^{\circ}C)$, versus junction temperature T_j .



BTA216 series D, E and F

MECHANICAL DATA



Notes

Refer to mounting instructions for SOT78 (TO220) envelopes.
 Epoxy meets UL94 V0 at 1/8".

BTA216 series D, E and F

DEFINITIONS

Data sheet status					
Objective specification	This data sheet contains target or goal specifications for product development.				
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.				
Product specification	This data sheet contains final product specifications.				

Limiting values

Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

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